

AOT264L-VB Datasheet N-Channel 60 V (D-S) MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	60			
$R_{DS(on)}(\Omega)$ at $V_{GS} = 10 \text{ V}$	0.0016			
$R_{DS(on)}(\Omega)$ at $V_{GS} = 4.5 \text{ V}$	0.0020			
I _D (A)	270			
Configuration	Single			

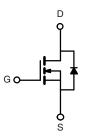
FEATURES

- Trench power MOSFET
- Package with low thermal resistance
- \bullet 100 % $R_{\rm g}$ and UIS tested



1





N-Channel N	MOSFET
-------------	--------

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)					
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V_{DS}	60	V	
Gate-Source Voltage		V_{GS}	± 20	V	
Continuous Drain Current	T _C = 25 °C	- I _D	270		
	T _C = 125 °C		120 ^a		
Continuous Source Current (Diode Conduction)	I _S	120 ^a	Α		
Pulsed Drain Current ^b	I _{DM}	600			
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	75		
Single Pulse Avalanche Energy	L=0.1 IIII	E _{AS}	281	mJ	
Maximum Power Dissipation ^b	T _C = 25 °C	В	375	W	
	T _C = 125 °C	P_{D}	125	VV	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55 to +175	°C	

THERMAL RESISTANCE RATINGS					
PARAMETER		SYMBOL	LIMIT	UNIT	
Junction-to-Ambient	PCB Mount c	R_{thJA}	40	°C/W	
Junction-to-Case (Drain)		R_{thJC}	0.4	G/ VV	

Notes

- a. Package limited.
- b. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.
- c. When mounted on 1" square PCB (FR4 material).



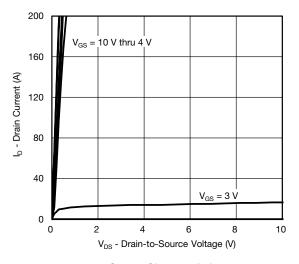
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT	
Static	1			l				
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		60	-	_	V	
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	$V_{DS} = V_{GS}, I_D = 250 \mu A$		2.0	2.5	V	
Gate-Source Leakage	I _{GSS}	V _{DS} =	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$		-	± 100	nA	
		$V_{GS} = 0 V$	V _{DS} = 60 V	-	-	1		
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V$	V _{DS} = 60 V, T _J = 125 °C	-	-	50	μA	
		$V_{GS} = 0 V$	V _{DS} = 60 V, T _J = 175 °C	-	-	1.5	mA	
On-State Drain Current ^a	I _{D(on)}	V _{GS} = 10 V	$V_{DS} \ge 5 \text{ V}$	120	-	-	Α	
		V _{GS} = 10 V	I _D = 30 A	-	0.0016	-	Ω	
Drain-Source On-State Resistance a	D	V _{GS} = 10 V	I _D = 30 A, T _J = 125 °C	-	0.0031	-		
Diani-Source On-State nesistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 30 A, T _J = 175 °C	-	0.0037	-		
		$V_{GS} = 4.5 \text{ V}$	I _D = 20 A	-	0.0020	-		
Forward Transconductance b	9fs	V _{DS} = 15 V, I _D = 30 A		-	164	-	S	
Dynamic ^b								
Input Capacitance	C _{iss}		V _{DS} = 25 V, f = 1 MHz	-	12 060	15 100	pF	
Output Capacitance	C _{oss}	$V_{GS} = 0 V$		-	5750	7200		
Reverse Transfer Capacitance	C _{rss}			-	860	1100		
Total Gate Charge ^c	Q_g			-	128	200		
Gate-Source Charge ^c	Q_{gs}	V _{GS} = 10 V	$V_{DS} = 30 \text{ V}, I_{D} = 80 \text{ A}$	-	33	-	nC	
Gate-Drain Charge ^c	Q_{gd}			-	11	-		
Gate Resistance	Rg		f = 1 MHz		1.68	2.6	Ω	
Turn-On Delay Time ^c	t _{d(on)}				20	25		
Rise Time ^c	t _r	V_{DD} = 30 V, R_L = 0.375 Ω I_D \cong 80 A, V_{GEN} = 10 V, R_g = 1 Ω		-	15	40	- ns	
Turn-Off Delay Time ^c	t _{d(off)}			-	65	100		
Fall Time ^c	t _f			-	12	20		
Source-Drain Diode Ratings and Chara	acteristics ^b							
Pulsed Current ^a	I _{SM}			-	-	300	Α	
Forward Voltage	V_{SD}	I _F = 80 A, V _{GS} = 0 V		_	0.88	1.5	V	

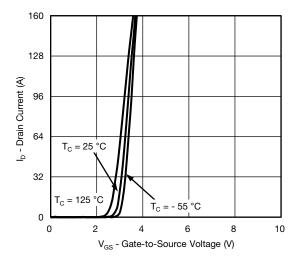
Notes

- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.
- c. Independent of operating temperature.



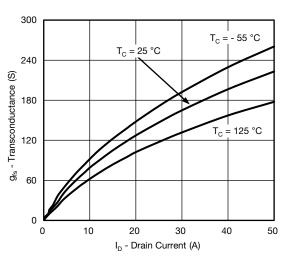
TYPICAL CHARACTERISTICS (T_A = 25 °C, unless otherwise noted)

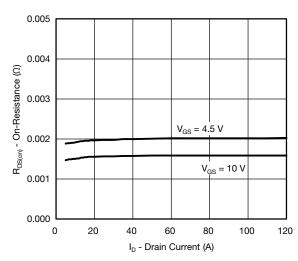




Output Characteristics

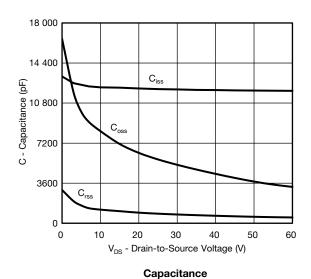
Transfer Characteristics

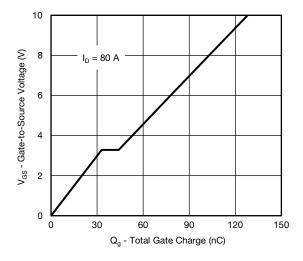




Transconductance

On-Resistance vs. Drain Current

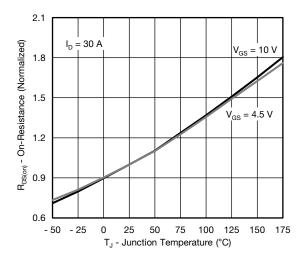




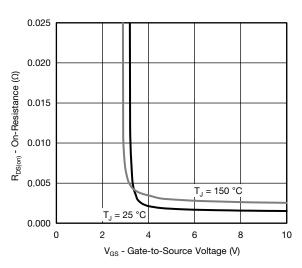
Gate Charge



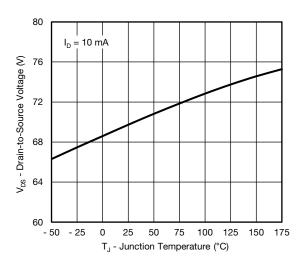
TYPICAL CHARACTERISTICS ($T_A = 25$ °C, unless otherwise noted)



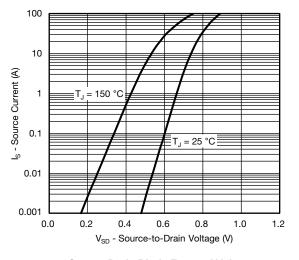
On-Resistance vs. Junction Temperature



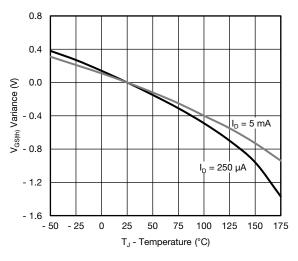
On-Resistance vs. Gate-to-Source Voltage



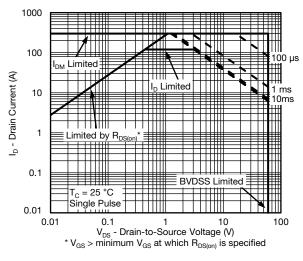
Drain Source Breakdown vs. Junction Temperature



Source Drain Diode Forward Voltage



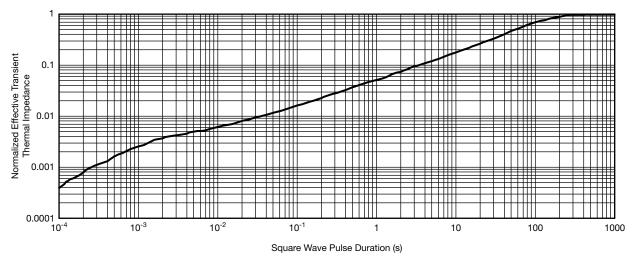
Threshold Voltage



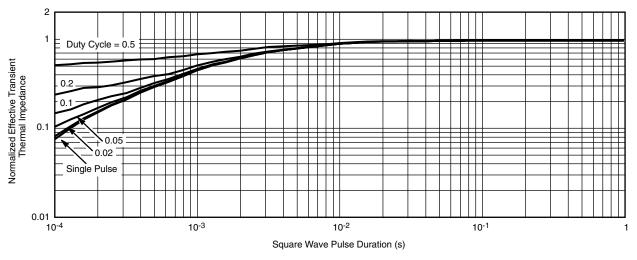
Safe Operating Area



THERMAL RATINGS (T_A = 25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



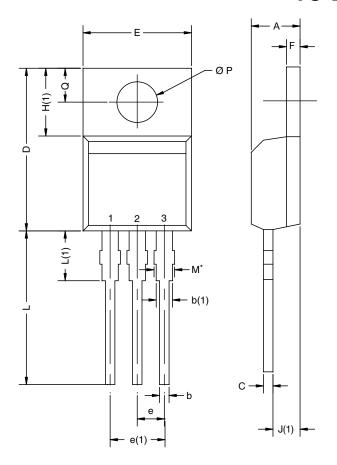
Normalized Thermal Transient Impedance, Junction-to-Case

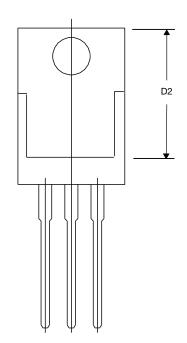
Note

- The characteristics shown in the two graphs
 - Normalized Transient Thermal Impedance Junction-to-Ambient (25 °C)
 - Normalized Transient Thermal Impedance Junction-to-Case (25 °C) are given for general guidelines only to enable the user to get a "ball park" indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual application parameters and operating conditions.



TO-220AB





		INC	HES	MILLIMETERS				
DIM.		MIN.	MAX.	MIN.	MAX.			
Α		0.160	0.190	4.064	4.826			
	b	0.020	0.039	0.508	0.990			
	b1	0.020	0.035	0.508	0.889			
	b2	0.045	0.055	1.143	1.397			
C*	Thin lead	0.013	0.018	0.330	0.457			
	Thick lead	0.023	0.028	0.584	0.711			
	Thin lead	0.013	0.017	0.330	0.431			
c1	Thick lead	0.023	0.027	0.584	0.685			
	c2	0.045	0.055	1.143	1.397			
	D	0.340	0.380	8.636	9.652			
D1		0.220	0.240	5.588	6.096			
D2		D2 0.038		0.965	1.067			
	D3	0.045	0.055	1.143	1.397			
D4		0.044	0.052	1.118	1.321			
Е		0.380	0.410	9.652	10.414			
E1		0.245	-	6.223	-			
E2		0.355	0.375	9.017	9.525			
E3		0.072	0.078	1.829	1.981			
e		0.100 BSC		2.54 BSC				
K		0.045	0.055	1.143	1.397			
L		0.575	0.625	14.605	15.875			
L1		0.090	0.110	2.286	2.794			
L2		0.040	0.055	1.016	1.397			
L3		L3 0.050		1.270	1.778			
L4		0.010	BSC	0.254 BSC				
M		-	0.002	-	0.050			

ECN: T13-0707-Rev. K, 30-Sep-13

DWG: 5843

Notes

- 1. Plane B includes maximum features of heat sink tab and plastic.
- 2. No more than 25 % of L1 can fall above seating plane by max. 8 mils.
- 3. Pin-to-pin coplanarity max. 4 mils.
- 4. *: Thin lead is for SUB, SYB.
 - Thick lead is for SUM, SYM, SQM.
- 5. Use inches as the primary measurement.

6. This feature is for thick lead.



Disclaimer

All products due to improve reliability, function or design or for other reasons, product specifications and data are subject to change without notice.

Taiwan VBsemi Electronics Co., Ltd., branches, agents, employees, and all persons acting on its or their representatives (collectively, the "Taiwan VBsemi"), assumes no responsibility for any errors, inaccuracies or incomplete data contained in the table or any other any disclosure of any information related to the product.(www.VBsemi.com)

Taiwan VBsemi makes no guarantee, representation or warranty on the product for any particular purpose of any goods or continuous production. To the maximum extent permitted by applicable law on Taiwan VBsemi relinquished: (1) any application and all liability arising out of or use of any products; (2) any and all liability, including but not limited to special, consequential damages or incidental; (3) any and all implied warranties, including a particular purpose, non-infringement and merchantability guarantee.

Statement on certain types of applications are based on knowledge of the product is often used in a typical application of the general product VBsemi Taiwan demand that the Taiwan VBsemi of. Statement on whether the product is suitable for a particular application is non-binding. It is the customer's responsibility to verify specific product features in the products described in the specification is appropriate for use in a particular application. Parameter data sheets and technical specifications can be provided may vary depending on the application and performance over time. All operating parameters, including typical parameters must be made by customer's technical experts validated for each customer application. Product specifications do not expand or modify Taiwan VBsemi purchasing terms and conditions, including but not limited to warranty herein.

Unless expressly stated in writing, Taiwan VBsemi products are not intended for use in medical, life saving, or life sustaining applications or any other application. Wherein VBsemi product failure could lead to personal injury or death, use or sale of products used in Taiwan VBsemi such applications using client did not express their own risk. Contact your authorized Taiwan VBsemi people who are related to product design applications and other terms and conditions in writing.

The information provided in this document and the company's products without a license, express or implied, by estoppel or otherwise, to any intellectual property rights granted to the VBsemi act or document. Product names and trademarks referred to herein are trademarks of their respective representatives will be all.

Material Category Policy

Taiwan VBsemi Electronics Co., Ltd., hereby certify that all of the products are determined to be oHS compliant and meets the definition of restrictions under Directive of the European Parliament 2011/65 / EU, 2011 Nian. 6. 8 Ri Yue restrict the use of certain hazardous substances in electrical and electronic equipment (EEE) - modification, unless otherwise specified as inconsistent.(www.VBsemi.com)

Please note that some documents may still refer to Taiwan VBsemi RoHS Directive 2002/95 / EC. We confirm that all products identified as consistent with the Directive 2002/95 / EC European Directive 2011/65 /.

Taiwan VBsemi Electronics Co., Ltd. hereby certify that all of its products comply identified as halogen-free halogen-free standards required by the JEDEC JS709A. Please note that some Taiwanese VBsemi documents still refer to the definition of IEC 61249-2-21, and we are sure that all products conform to confirm compliance with IEC 61249-2-21 standard level JS709A.